

**Notice of References Cited**Application No.  
**08/698,091**Applicant(s)  
**Lawler et al.**Examiner  
**Hosain T. Alam**Group Art Unit  
**2771**

Page 1 of 1

**U.S. PATENT DOCUMENTS**

|   | DOCUMENT NO. | DATE    | NAME            | CLASS | SUBCLASS |
|---|--------------|---------|-----------------|-------|----------|
| A | 5,159,687    | 09/1989 | Richburg        | 707   | 5        |
| B | 5,261,100    | 06/1989 | Fujinami et al. | 395   | 702      |
| C | 5,526,522    | 03/1992 | Takeuchi        | 395   | 702      |
| D | 5,606,661    | 06/1995 | Wear et al.     | 395   | 183.14   |
| E | 5,699,310    | 01/1994 | Garloff et al.  | 395   | 701      |
| F | 5,123,103    | 10/1987 | Ohtaki et al.   | 707   | 5        |
| G |              |         |                 |       |          |
| H |              |         |                 |       |          |
| I |              |         |                 |       |          |
| J |              |         |                 |       |          |
| K |              |         |                 |       |          |
| L |              |         |                 |       |          |
| M |              |         |                 |       |          |

**FOREIGN PATENT DOCUMENTS**

|   | DOCUMENT NO. | DATE | COUNTRY | NAME | CLASS | SUBCLASS |
|---|--------------|------|---------|------|-------|----------|
| N |              |      |         |      |       |          |
| O |              |      |         |      |       |          |
| P |              |      |         |      |       |          |
| Q |              |      |         |      |       |          |
| R |              |      |         |      |       |          |
| S |              |      |         |      |       |          |
| T |              |      |         |      |       |          |

**NON-PATENT DOCUMENTS**

|   | DOCUMENT (Including Author, Title, Source, and Pertinent Pages)   | DATE    |
|---|---|---------|
| U | "Towards a Framework for Software Measurement Validation", Kitchenham et al., IEEE Transactions on Software Engineering, vol. 21, no. 12, pages 929-944 | 12/1995 |
| V |   |         |
| W |   |         |
| X |   |         |